## NVMFD5C446N

## Power MOSFET <br> 40 V, $2.9 \mathrm{~m} \Omega$, 127 A, Dual N-Channel

## Features

- Small Footprint ( $5 \times 6 \mathrm{~mm}$ ) for Compact Design
- Low $\mathrm{R}_{\mathrm{DS}(\text { on })}$ to Minimize Conduction Losses
- Low $\mathrm{Q}_{\mathrm{G}}$ and Capacitance to Minimize Driver Losses
- NVMFD5C446NWF - Wettable Flank Option for Enhanced Optical Inspection
- AEC-Q101 Qualified and PPAP Capable
- These Devices are $\mathrm{Pb}-$ Free and are RoHS Compliant

MAXIMUM RATINGS $\left(T_{J}=25^{\circ} \mathrm{C}\right.$ unless otherwise noted)

| Parameter |  |  | Symbol | Value | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: |
| Drain-to-Source Voltage |  |  | $\mathrm{V}_{\text {DSS }}$ | 40 | V |
| Gate-to-Source Voltage |  |  | $\mathrm{V}_{\mathrm{GS}}$ | $\pm 20$ | V |
| Continuous Drain Current $\mathrm{R}_{\text {日JC }}$ (Notes 1, 2, 3) | Steady State | $\mathrm{T}_{\mathrm{C}}=25^{\circ} \mathrm{C}$ | ID | 127 | A |
|  |  | $\mathrm{T}_{\mathrm{C}}=100^{\circ} \mathrm{C}$ |  | 90 |  |
| Power Dissipation <br> $\mathrm{R}_{\text {өJC }}$ (Notes 1, 2) |  | $\mathrm{T}_{\mathrm{C}}=25^{\circ} \mathrm{C}$ | $\mathrm{P}_{\mathrm{D}}$ | 89 | W |
|  |  | $\mathrm{T}_{\mathrm{C}}=100^{\circ} \mathrm{C}$ |  | 44 |  |
| Continuous Drain Current $\mathrm{R}_{\theta \mathrm{JA}}$ (Notes 1, 2, 3) | Steady State | $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$ | ID | 24 | A |
|  |  | $\mathrm{T}_{\mathrm{A}}=100^{\circ} \mathrm{C}$ |  | 17 |  |
| Power Dissipation <br> $\mathrm{R}_{\theta \mathrm{JA}}$ (Notes 1 \& 2) |  | $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$ | $\mathrm{P}_{\mathrm{D}}$ | 3.2 | W |
|  |  | $\mathrm{T}_{\mathrm{A}}=100^{\circ} \mathrm{C}$ |  | 1.6 |  |
| Pulsed Drain Current | $\mathrm{T}_{\mathrm{A}}=25$ | $\mathrm{C}, \mathrm{t}_{\mathrm{p}}=10 \mu \mathrm{~s}$ | IDM | 637 | A |
| Operating Junction and Storage Temperature |  |  | $\mathrm{T}_{\mathrm{J}}, \mathrm{T}_{\text {stg }}$ | $\begin{gathered} -55 \text { to } \\ +175 \end{gathered}$ | ${ }^{\circ} \mathrm{C}$ |
| Source Current (Body Diode) |  |  | Is | 74 | A |
| Single Pulse Drain-to-Source Avalanche Energy $\left(T_{J}=25^{\circ} \mathrm{C}, \mathrm{I}_{\mathrm{L}(\mathrm{pk})}=11 \mathrm{~A}\right)$ |  |  | $\mathrm{E}_{\text {AS }}$ | 223 | mJ |
| Lead Temperature for Soldering Purposes ( $1 / 8^{\prime \prime}$ from case for 10 s ) |  |  | $\mathrm{T}_{\mathrm{L}}$ | 260 | ${ }^{\circ} \mathrm{C}$ |

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL RESISTANCE MAXIMUM RATINGS

| Parameter | Symbol | Value | Unit |
| :--- | :---: | :---: | :---: |
| Junction-to-Case - Steady State | $\mathrm{R}_{\theta \mathrm{JC}}$ | 1.7 | \multirow{7}\mathrm{C}$/ \mathrm{W}$ |
| Junction-to-Ambient - Steady State (Note 2) | $\mathrm{R}_{\theta \mathrm{JJ}}$ | 47 |  |

1. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
2. Surface-mounted on FR4 board using a $650 \mathrm{~mm}^{2}$, 2 oz. Cu pad.
3. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

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| $\mathbf{V}_{\text {(BR)DSS }}$ | $\mathbf{R}_{\mathbf{D S}(\mathbf{O N})}$ MAX | $\mathbf{I}_{\mathbf{D}}$ MAX |
| :---: | :---: | :---: |
| 40 V | $2.9 \mathrm{~m} \Omega @ 10 \mathrm{~V}$ | 127 A |



## ORDERING INFORMATION

See detailed ordering, marking and shipping information on page 5 of this data sheet.

ELECTRICAL CHARACTERISTICS $\left(T_{J}=25^{\circ} \mathrm{C}\right.$ unless otherwise specified)


ON CHARACTERISTICS (Note 4)

| Gate Threshold Voltage | $\mathrm{V}_{\mathrm{GS}(\mathrm{TH})}$ | $\mathrm{V}_{\mathrm{GS}}=\mathrm{V}_{\mathrm{DS}}, \mathrm{I}_{\mathrm{D}}=250 \mu \mathrm{~A}$ | 2.5 |  | 3.5 | V |
| :--- | :---: | :---: | :---: | :---: | :---: | :---: |
| Threshold Temperature Coefficient | $\mathrm{V}_{\mathrm{GS}(\mathrm{TH})} / \mathrm{T}_{\mathrm{J}}$ |  |  | -6.4 |  | $\mathrm{mV} /{ }^{\circ} \mathrm{C}$ |
| Drain-to-Source On Resistance | $\mathrm{R}_{\mathrm{DS}(\mathrm{on})}$ | $\mathrm{V}_{\mathrm{GS}}=10 \mathrm{~V}$ | $\mathrm{I}_{\mathrm{D}}=30 \mathrm{~A}$ |  | 2.4 | 2.9 |

CHARGES, CAPACITANCES \& GATE RESISTANCE

| Input Capacitance | $\mathrm{C}_{\text {ISS }}$ | $\mathrm{V}_{\mathrm{GS}}=0 \mathrm{~V}, \mathrm{f}=1 \mathrm{MHz}, \mathrm{V}_{\mathrm{DS}}=25 \mathrm{~V}$ | 2450 | pF |
| :---: | :---: | :---: | :---: | :---: |
| Output Capacitance | Coss |  | 1200 |  |
| Reverse Transfer Capacitance | $\mathrm{C}_{\mathrm{RSS}}$ |  | 44 |  |
| Total Gate Charge | $\mathrm{Q}_{\mathrm{G}(\text { (TOT) }}$ | $\mathrm{V}_{\mathrm{GS}}=10 \mathrm{~V}, \mathrm{~V}_{\mathrm{DS}}=32 \mathrm{~V} ; \mathrm{I}_{\mathrm{D}}=30 \mathrm{~A}$ | 38 | nC |
| Threshold Gate Charge | $\mathrm{Q}_{\mathrm{G}(\mathrm{TH})}$ |  | 7.0 |  |
| Gate-to-Source Charge | $Q_{G S}$ |  | 11 |  |
| Gate-to-Drain Charge | $\mathrm{Q}_{\mathrm{GD}}$ |  | 7.0 |  |
| Plateau Voltage | $\mathrm{V}_{\mathrm{GP}}$ |  | 4.5 | V |

SWITCHING CHARACTERISTICS (Note 5)

| Turn-On Delay Time | $\mathrm{t}_{\mathrm{d}(\mathrm{ON})}$ | $\begin{gathered} \mathrm{V}_{\mathrm{GS}}=10 \mathrm{~V}, \mathrm{~V}_{\mathrm{DS}}=32 \mathrm{~V}, \\ \mathrm{I}_{\mathrm{D}}=30 \mathrm{~A}, \mathrm{R}_{\mathrm{G}}=1.0 \Omega \end{gathered}$ | 18 | ns |
| :---: | :---: | :---: | :---: | :---: |
| Rise Time | $t_{r}$ |  | 39 |  |
| Turn-Off Delay Time | $\mathrm{t}_{\mathrm{d} \text { (OFF) }}$ |  | 47 |  |
| Fall Time | $t_{f}$ |  | 17 |  |

DRAIN-SOURCE DIODE CHARACTERISTICS

| Forward Diode Voltage | $\mathrm{V}_{\text {SD }}$ | $\begin{aligned} & \mathrm{V}_{\mathrm{GS}}=0 \mathrm{~V}, \\ & \mathrm{I}_{\mathrm{S}}=30 \mathrm{~A} \end{aligned}$ | $\mathrm{T}_{J}=25^{\circ} \mathrm{C}$ | 0.8 | 1.2 | V |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | $\mathrm{T}_{\mathrm{J}}=125^{\circ} \mathrm{C}$ | 0.7 |  |  |
| Reverse Recovery Time | $\mathrm{t}_{\mathrm{RR}}$ | $\begin{gathered} \mathrm{V}_{\mathrm{GS}}=0 \mathrm{~V}, \mathrm{dIS} / \mathrm{dt}=100 \mathrm{~A} / \mathrm{us}, \\ \mathrm{I}_{\mathrm{S}}=30 \mathrm{~A} \end{gathered}$ |  | 50 |  | ns |
| Charge Time | $\mathrm{t}_{\mathrm{a}}$ |  |  | 25 |  |  |
| Discharge Time | $\mathrm{t}_{\mathrm{b}}$ |  |  | 25 |  |  |
| Reverse Recovery Charge | $\mathrm{Q}_{\text {RR }}$ |  |  | 35 |  | nC |

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.
4. Pulse Test: pulse width $\leq 300 \mu \mathrm{~s}$, duty cycle $\leq 2 \%$.
5. Switching characteristics are independent of operating junction temperatures.

## NVMFD5C446N

TYPICAL CHARACTERISTICS


Figure 1. On-Region Characteristics



Figure 3. On-Resistance vs. Gate-to-Source Voltage


Figure 5. On-Resistance Variation with Temperature


Figure 2. Transfer Characteristics


Figure 4. On-Resistance vs. Drain Current and Gate Voltage


Figure 6. Drain-to-Source Leakage Current vs. Voltage

## NVMFD5C446N

## TYPICAL CHARACTERISTICS



Figure 7. Capacitance Variation

$\mathrm{R}_{\mathrm{G}}$, GATE RESISTANCE ( $\Omega$ )
Figure 9. Resistive Switching Time Variation vs. Gate Resistance


Figure 11. Maximum Rated Forward Biased Safe Operating Area


Figure 8. Gate-to-Source vs. Total Charge


Figure 10. Diode Forward Voltage vs. Current


Figure 12. Maximum Drain Current vs. Time in Avalanche

## NVMFD5C446N

## TYPICAL CHARACTERISTICS



Figure 13. Thermal Response

DEVICE ORDERING INFORMATION

| Device | Marking | Package | Shipping $^{\dagger}$ |
| :--- | :---: | :---: | :---: |
| NVMFD5C446NT1G | 5 C446N | DFN8 <br> (Pb-Free) | $1500 /$ Tape \& Reel |
| NVMFD5C446NWFT1G | 446 NWF | DFN8 <br> (Pb-Free, Wettable Flanks) | $1500 /$ Tape \& Reel |

$\dagger$ For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.


SCALE 2:1

DFN8 5x6, 1.27P Dual Flag (SO8FL-Dual)
CASE 506BT
ISSUE F
DATE 23 NOV 2021


1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994
2. CONTROLLING DIMENSION: MILLIMETERS.
3. DIMENSION b APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN 0.15 AND 0.30 MM FROM THE TERMINAL TIP.
4. PROFILE TOLERANCE APPLIES TO THE EXPOSED PAD AS WELL AS THE TERMINALS.
5. DIMENSIONS D1 AND E1 DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS.
6. SEATING PLANE IS DEFINED BY THE TERMINALS. A1 IS DEFINED AS THE DISTANCE FROM THE SEATING PLANE TO THE LOWEST POINT ON THE PACKAGE BODY.
7. A VISUAL INDICATOR FOR PIN 1 MUST BE LOCATED IN THIS AREA.


GENERIC
MARKING DIAGRAM*


XXXXXX = Specific Device Code
A =Assembly Location
Y = Year
W = Work Week
ZZ = Lot Traceability

*For additional information on our $\mathrm{Pb}-$ Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.
*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " $\mathbf{r}$ ", may or may not be present. Some products may not follow the Generic Marking.

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| ---: | :--- | :--- | :--- |
| DESCRIPTION: | DFN8 5X6, 1.27P DUAL FLAG (SO8FL-DUAL) | PAGE 1 OF 1 |

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